

Rev. 1 — 4 October 2011

Product data sheet

1. Product profile

1.1 General description

Planar passivated four quadrant triac in a SOT78 (TO-220AB) plastic package intended for use in general purpose bidirectional switching and phase control applications. This sensitive gate "series E" triac is intended to be interfaced directly to microcontrollers, logic integrated circuits and other low power gate trigger circuits.

1.2 Features and benefits

- Direct triggering from low power drivers and logic ICs
- High blocking voltage capability
- Planar passivated for voltage ruggedness and reliability
- Sensitive gate for easy logic level triggering
- Triggering in all four quadrants

1.3 Applications

General purpose motor control

General purpose switching

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DRM}	repetitive peak off-state voltage		-	-	800	V
I _{TSM}	non-repetitive peak on-state current	full sine wave; $T_{j(init)} = 25$ °C; $t_p = 20$ ms; see Figure 4; see Figure 5	-	-	35	Α
I _{T(RMS)}	RMS on-state current	full sine wave; $T_{mb} \le 110 ^{\circ}\text{C}$; see <u>Figure 1</u> ; see <u>Figure 2</u> ; see <u>Figure 3</u>	-	-	4	Α
Static cha	racteristics					
I _{GT}	gate trigger current	$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2+G+;$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 7}}{}$	-	-	10	mA
		$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2 + G-;$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 7}}{\text{ or } T_j}$	-	-	10	mA
		$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2\text{- G-;} $ $T_j = 25 \text{ °C; see } \frac{\text{Figure 7}}{\text{ C}}$	-	-	10	mA
		$V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2\text{- }G\text{+;} $ $T_j = 25 \text{ °C; see } \underline{\text{Figure 7}}$	-	-	25	mA



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	T1	main terminal 1		N 1
2	T2	main terminal 2	mb	T2—T1
3	G	gate	7 0 1	sym051
mb	T2	mounting base; main terminal 2		
			SOT78 (TO-220AB)	

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BT234-800E	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DRM}	repetitive peak off-state voltage		-	800	V
$I_{T(RMS)}$	RMS on-state current	full sine wave; T _{mb} ≤ 110 °C; see <u>Figure 1</u> ; see <u>Figure 2</u> ; see <u>Figure 3</u>	-	4	Α
I _{TSM}	non-repetitive peak on-state current	full sine wave; $T_{j(init)} = 25 ^{\circ}C$; $t_p = 20 \text{ms}$; see Figure 4; see Figure 5	-	35	Α
		full sine wave; $T_{j(init)} = 25$ °C; $t_p = 16.7$ ms	-	38.5	Α
I ² t	I ² t for fusing	t _p = 10 ms; sine-wave pulse	-	6.1	A ² s
dl _T /dt	rate of rise of on-state current	$I_T = 7 \text{ A}$; $I_G = 0.2 \text{ A}$; $dI_G/dt = 0.2 \text{ A/}\mu\text{s}$; $T2+ G+$	-	50	A/µs
		$I_T = 7 \text{ A}$; $I_G = 0.2 \text{ A}$; $dI_G/dt = 0.2 \text{ A/}\mu\text{s}$; T2+ G-	-	50	A/µs
		$I_T = 7 \text{ A}$; $I_G = 0.2 \text{ A}$; $dI_G/dt = 0.2 \text{ A/}\mu\text{s}$; T2- G-	-	50	A/µs
		$I_T = 7 \text{ A}$; $I_G = 0.2 \text{ A}$; $dI_G/dt = 0.2 \text{ A/}\mu\text{s}$; T2- G+	-	10	A/µs
I _{GM}	peak gate current		-	2	Α
P_GM	peak gate power		-	5	W
$P_{G(AV)}$	average gate power	over any 20 ms period	-	0.5	W
T _{stg}	storage temperature		-40	150	°C
T _i	junction temperature		-	125	°C

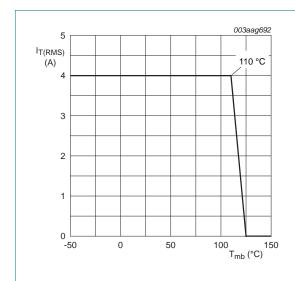
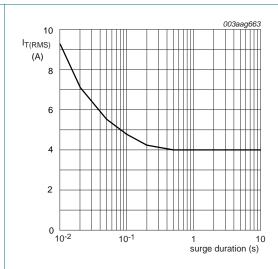
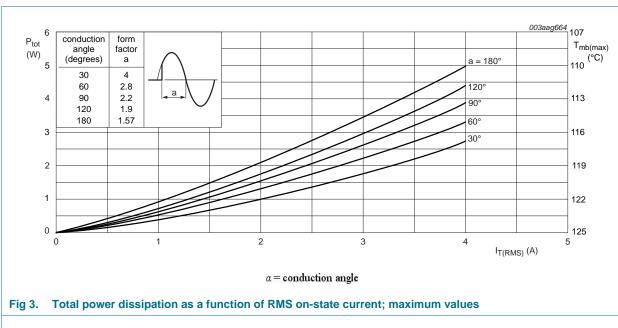


Fig 1. RMS on-state current as a function of mounting base temperature; maximum values



f = 50 Hz; T_{mb} = 110 $^{\circ}\mathrm{C}$

Fig 2. RMS on-state current as a function of surge duration; maximum values



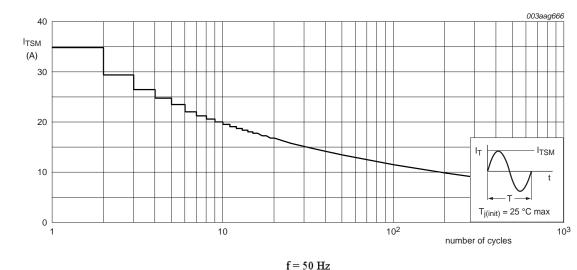
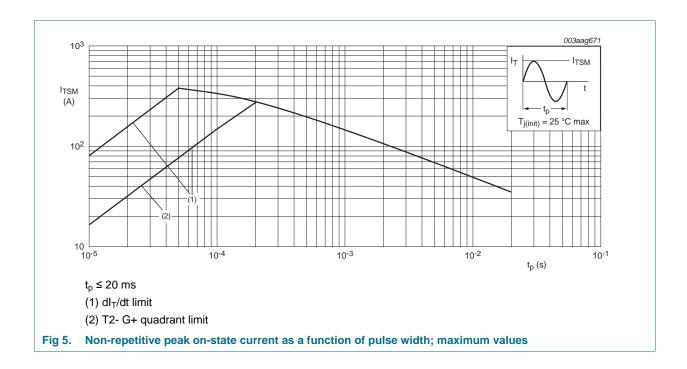


Fig 4. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values

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5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j\text{-}mb)}$	thermal resistance from junction to mounting base	half cycle; see Figure 6	-	-	3.7	K/W
		full cycle; see Figure 6	-	-	3	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	-	60	-	K/W

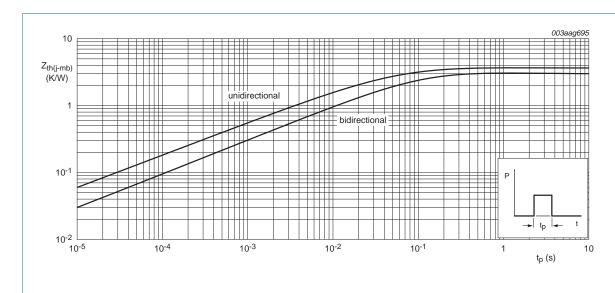
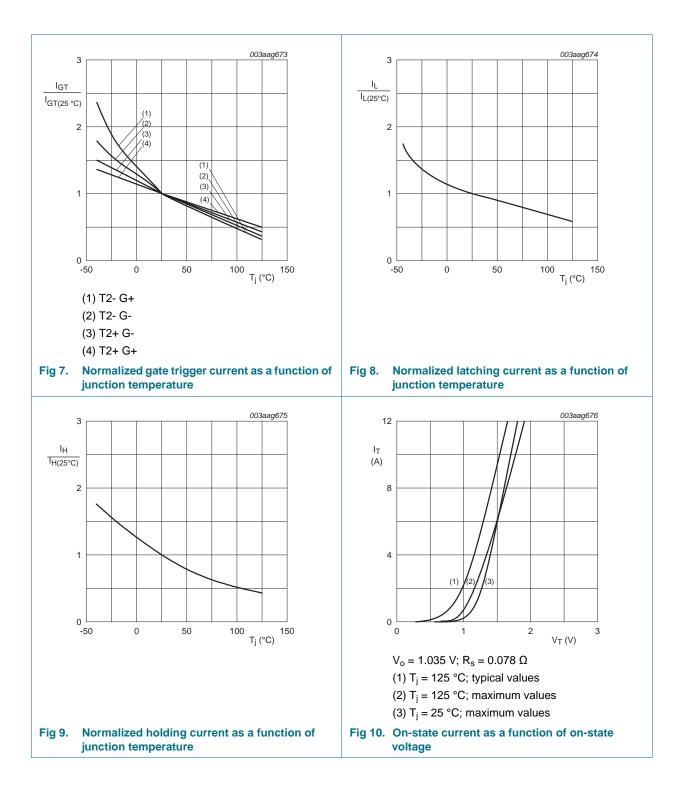


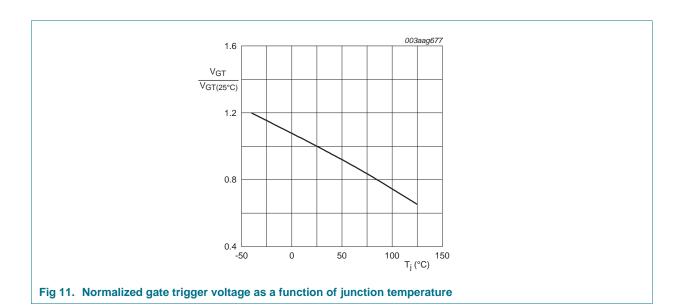
Fig 6. Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Characteristics

Table 6. Characteristics

Parameter	Conditions	Min	Тур	Max	Unit
Static characteristics					
gate trigger current	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2+G+; T_j = 25 ^{\circ}\text{C};$ see Figure 7	-	-	10	mA
	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2+ G-; T_j = 25 ^C;$ see Figure 7	-	-	10	mA
	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2- G-; T_j = 25 ^{\circ}C;$ see Figure 7	-	-	10	mA
	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T2- G+; T_j = 25 °C;$ see Figure 7	-	-	25	mA
latching current	$V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; T2+ G+; T_j = 25 ^{\circ}\text{C};$ see Figure 8	-	-	15	mA
	$V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; T2+ G-; T_j = 25 ^{\circ}\text{C};$ see Figure 8	-	-	25	mA
	$V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; \text{ T2- G-}; T_j = 25 \text{ °C};$ see Figure 8	-	-	15	mA
	$V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; T2-G+; T_j = 25 ^{\circ}\text{C};$ see Figure 8	-	-	15	mA
holding current	V _D = 12 V; T _j = 25 °C; see <u>Figure 9</u>	-	-	15	mΑ
on-state voltage	I _T = 6 A; T _j = 25 °C; see <u>Figure 10</u>	-	1.3	1.5	V
gate trigger voltage	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; T_j = 25 \text{ °C};$ see Figure 11	-	0.7	1.5	V
	$V_D = 400 \text{ V}; I_T = 0.1 \text{ A}; T_j = 125 \text{ °C};$ see Figure 11	0.25	0.4	-	V
off-state current	V _D = 800 V; T _j = 125 °C	-	0.1	0.5	mΑ
characteristics					
rate of rise of off-state voltage	V_{DM} = 536 V; T_j = 125 °C; exponential waveform; gate open circuit	80	-	-	V/µs
rate of change of commutating voltage	V_D = 400 V; T_j = 125 °C; dI_{com}/dt = 1.8 A/ms; I_T = 4 A; gate open circuit	15	-	-	V/µs
rate of change of commutating current	$V_D = 400 \text{ V}; T_j = 125 \text{ °C}; I_{T(RMS)} = 4 \text{ A};$ (snubberless condition); gate open circuit	1.5	-	-	A/ms
gate-controlled turn-on time	$I_{TM} = 6 \text{ A}; V_D = 800 \text{ V}; I_G = 0.1 \text{ A};$ $dI_G/dt = 5 \text{ A}/\mu\text{s}$	-	2	-	μs
	pate trigger current latching current holding current on-state voltage gate trigger voltage off-state current characteristics rate of rise of off-state voltage rate of change of commutating voltage rate of change of commutating current	gate trigger current $ \begin{array}{c} V_D = 12 \ V; \ I_T = 0.1 \ A; \ T2+ \ G+; \ T_j = 25 \ ^{\circ}C; \\ see \ Figure \ 7 \\ \hline V_D = 12 \ V; \ I_T = 0.1 \ A; \ T2+ \ G-; \ T_j = 25 \ ^{\circ}C; \\ see \ Figure \ 7 \\ \hline V_D = 12 \ V; \ I_T = 0.1 \ A; \ T2- \ G-; \ T_j = 25 \ ^{\circ}C; \\ see \ Figure \ 7 \\ \hline V_D = 12 \ V; \ I_T = 0.1 \ A; \ T2- \ G+; \ T_j = 25 \ ^{\circ}C; \\ see \ Figure \ 7 \\ \hline \\ Iatching current \\ \hline V_D = 12 \ V; \ I_G = 0.1 \ A; \ T2- \ G+; \ T_j = 25 \ ^{\circ}C; \\ see \ Figure \ 8 \\ \hline V_D = 12 \ V; \ I_G = 0.1 \ A; \ T2+ \ G-; \ T_j = 25 \ ^{\circ}C; \\ see \ Figure \ 8 \\ \hline V_D = 12 \ V; \ I_G = 0.1 \ A; \ T2- \ G-; \ T_j = 25 \ ^{\circ}C; \\ see \ Figure \ 8 \\ \hline V_D = 12 \ V; \ I_G = 0.1 \ A; \ T2- \ G-; \ T_j = 25 \ ^{\circ}C; \\ see \ Figure \ 8 \\ \hline V_D = 12 \ V; \ I_G = 0.1 \ A; \ T2- \ G+; \ T_j = 25 \ ^{\circ}C; \\ see \ Figure \ 8 \\ \hline V_D = 12 \ V; \ I_J = 25 \ ^{\circ}C; \ see \ Figure \ 9 \\ \hline on-state \ voltage \\ \hline I_T = 6 \ A; \ T_j = 25 \ ^{\circ}C; \ see \ Figure \ 10 \\ \hline V_D = 12 \ V; \ I_T = 0.1 \ A; \ T_j = 125 \ ^{\circ}C; \\ see \ Figure \ 11 \\ \hline V_D = 800 \ V; \ I_T = 0.1 \ A; \ T_j = 125 \ ^{\circ}C; \\ see \ Figure \ 11 \\ \hline off-state \ current \\ \hline V_D = 800 \ V; \ T_j = 125 \ ^{\circ}C; \ exponential \\ waveform; \ gate \ open \ circuit \\ \hline rate \ of \ change \ of \\ commutating \ voltage \\ \hline V_D = 400 \ V; \ T_j = 125 \ ^{\circ}C; \ exponential \\ waveform; \ gate \ open \ circuit \\ \hline rate \ of \ change \ of \\ commutating \ current \\ \hline V_D = 400 \ V; \ T_j = 125 \ ^{\circ}C; \ exponential \\ waveform; \ gate \ open \ circuit \\ \hline rate \ of \ change \ of \\ commutating \ current \\ \hline V_D = 400 \ V; \ T_j = 125 \ ^{\circ}C; \ exponential \\ waveform; \ gate \ open \ circuit \\ \hline rate \ of \ change \ of \\ commutating \ current \\ \hline V_D = 400 \ V; \ T_j = 125 \ ^{\circ}C; \ exponential \\ \hline water \ of \ change \ of \\ commutating \ current \\ \hline \ V_D = 400 \ V; \ T_j = 125 \ ^{\circ}C; \ exponential \\ \hline \ V_D = 800 \ V; \ T_j = 125 \ ^{\circ}C; \ exponential \\ \hline \ V_D = 800 \ V; \ T_j = 125 \ ^{\circ}C; \ exponential \\ \hline \ V_D = 800 \ V; \ T_j = 125 \ ^{\circ}C; \ exponential \\ \hline \ V_D =$			





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7. Package outline

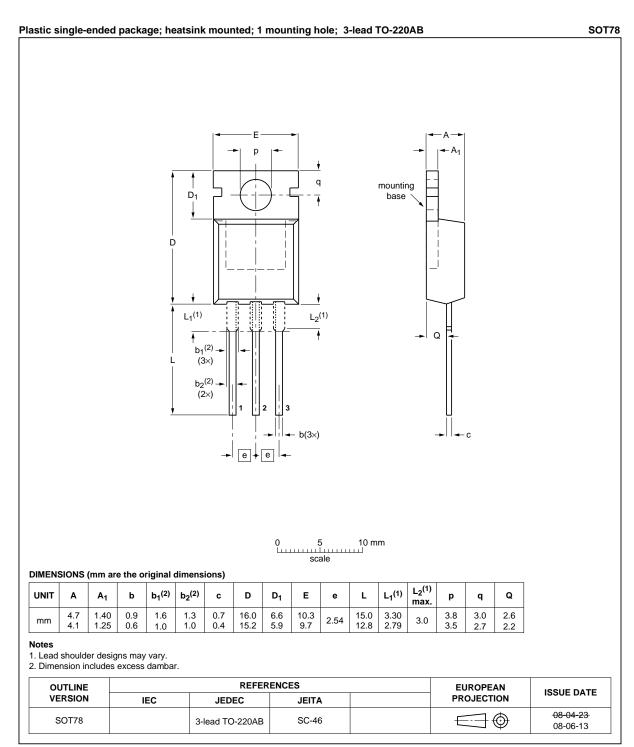


Fig 12. Package outline SOT78 (TO-220AB)

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8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BT234-800E v.1	20111004	Product data sheet	-	-

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9. Legal information

9.1 Data sheet status

Document status [1] [2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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